

**Notice of References Cited**

Application/Control No.

10/091,573

Applicant(s)/Patent Under  
Reexamination  
KRAENZEL ET AL.

Examiner

Dean T. Nguyen

Art Unit

3689

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*	B	US-2002/0149738	10-2002	McCormick, William	351/112
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**NON-PATENT DOCUMENTS**

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